## Efficient Conversion of NO<sub>2</sub> into N<sub>2</sub> and O<sub>2</sub> in N<sub>2</sub> or into N<sub>2</sub>O<sub>5</sub> in Air by 172-nm Xe<sub>2</sub> Excimer Lamp at Atmospheric Pressure

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Decomposition of NO<sub>2</sub> (200 ppm) in N<sub>2</sub> or air by 172-nm Xe<sub>2</sub> excimer lamp was studied at 1 atm. The NO<sub>2</sub> conversion in N<sub>2</sub> was 99%, and the formation ratios of N<sub>2</sub>, O<sub>2</sub>, NO, and N<sub>2</sub>O were 47, 98, 0, and 2%, respectively, after 30 min irradiation. The NO<sub>2</sub> in air (5–20% O<sub>2</sub>) could be completely converted to N<sub>2</sub>O<sub>5</sub> and HNO<sub>3</sub> due to reactions by O<sub>3</sub> and H<sub>2</sub>O after only 1.0–1.5 min irradiation. The present results give a new simple photochemical aftertreatment technique of NO<sub>2</sub> in air without using any catalysts.

We have recently initiated development of a photochemical method as a new promising removal method of NOx at atmospheric pressure without using expensive catalysts.<sup>1-4</sup> An advantage of photochemical method is that more selective decomposition is possible than electric discharge method, where energetic electrons are main energy carrier. We have recently studied decomposition of NO<sub>2</sub> into N<sub>2</sub> by using 193-nm ArF excimer laser in N<sub>2</sub> at atmospheric pressure.<sup>2</sup> Although more than 80% of NO<sub>2</sub> (200 ppm) could be converted into N<sub>2</sub>, O<sub>2</sub>, and NO in N<sub>2</sub> at atmospheric pressure, it was difficult to decompose NO<sub>2</sub> in air because after photolysis of NO<sub>2</sub> into NO + O (1a), such backward reaction (1b) occurs significantly.

$$NO_2 + h\nu (193 \text{ nm}) \rightarrow NO + O$$
 (1a)

$$NO + O + M \rightarrow NO_2 + M (M = N_2, O_2)$$
 (1b)

When ArF excimer laser photolysis was applied to practical NOx removal process, there are a lot of severe problems. They are that excimer laser apparatus is expensive, running cost is high, and the apparatus is big and heavy including high power sources. In order to overcome these problems, we used here a low cost and compact ( $\phi = 128$  mm, length = 330 mm) Xe<sub>2</sub> lamp as a new VUV right source. The absorption cross section of NO<sub>2</sub> ( $1.4 \times 10^{-17}$  cm<sup>2</sup> molecule<sup>-1</sup>) at 172 nm is 20 times larger than that ( $7.1 \times 10^{-19}$  cm<sup>2</sup> molecule<sup>-1</sup>) at 193 nm.<sup>5</sup> Therefore, more efficient photolysis of NO<sub>2</sub> is expected at 172 nm. We have found for the first time that NO<sub>2</sub> could be efficiently removed not only in N<sub>2</sub> atmosphere but also in air (5–20% O<sub>2</sub>) at a low NO<sub>2</sub> concentration of 200 ppm.

 $NO_2$  photolysis chamber used in this study was similar to that used for ArF laser photolysis<sup>1</sup> except for the VUV light source. Light from an unfocused 172-nm Xe<sub>2</sub> lamp (USHIO, UER20H172:50 mW/cm<sup>2</sup>, 155–200 nm range) was used to decompose  $NO_2$  at a room temperature. All experiments were carried out in a closed batch system. The total pressure was kept at atmospheric pressure, and the  $NO_2$  concentration diluted in  $N_2$ or  $N_2/O_2$  mixtures was 200 ppm (v/v). After 0.1–30 min photoirradiation, products were analyzed by using HORIBA gas analysis system (FG-100) equipped with an FTIR spectrometer and ANELVA gas analysis system (M-200GA-DTS) equipped with a quadrupole mass spectrometer. We determined the residual amount of NO<sub>2</sub>, [NO<sub>2</sub>]/[NO<sub>2</sub>]<sub>0</sub>, and the formation ratios of N<sub>2</sub>, O<sub>2</sub>, and NO<sub>x</sub>, defined as [N<sub>2</sub>]/ [NO<sub>2</sub>]<sub>0</sub>, [O<sub>2</sub>]/[NO<sub>2</sub>]<sub>0</sub>, and [NO<sub>x</sub>]/[NO<sub>2</sub>]<sub>0</sub>, respectively, from gas analyses. Here, [NO<sub>2</sub>]<sub>0</sub> is an initial concentration of NO<sub>2</sub>. N<sub>2</sub> and O<sub>2</sub> cannot be detected by FTIR, because these diatomic molecules are inactive for IR light. If other NO<sub>x</sub> and O<sub>3</sub> are produced in the photolysis, all of them can be detected. Thus, the formation ratios of N<sub>2</sub> and O<sub>2</sub> in N<sub>2</sub> were determined from N and O balance before and after photolysis.

When NO<sub>2</sub> was decomposed by a 172-nm excimer lamp for 20 min, the main absorption band of NO<sub>2</sub> at 1600 cm<sup>-1</sup> reduced its intensity, as shown in Figure S1 (Supporting Information).<sup>8</sup> Figure 1 shows the dependence of NO<sub>2</sub> conversion and the formation ratios of N<sub>2</sub>, O<sub>2</sub>, NO, and N<sub>2</sub>O on the irradiation time of lamp. After 30 min photoirradiation, the residual amount of NO<sub>2</sub> decreases to 1%, while the formation ratios of N<sub>2</sub> and O<sub>2</sub> increase to 47 and 98%, respectively. The formation ratio of NO initially increases to 9% until 2 min then gradually decreases to 0% in the 9–30 min range. The formation ratio of N<sub>2</sub>O can be kept as low as 3% in the all time range. On the basis of these results, NO<sub>2</sub> can be efficiently decomposed to N<sub>2</sub> and O<sub>2</sub> keeping NO and N<sub>2</sub>O emissions at low levels under 172 nm irradia-



Figure 1. Dependence of residual amount of  $NO_2$  and the formation ratios of products on the irradiation time of 172-nm excimer lamp at a  $NO_2$  concentration of 200 ppm in  $N_2$  at a total pressure of 1 atm.



Figure 2. Dependence of residual amount of  $NO_2$  and the formation ratios of products on the irradiation time of 172-nm excimer lamp at a  $NO_2$  concentration of 200 ppm in air (5%  $O_2$ ) at a total pressure of 1 atm.

tion, although it takes a long time to remove NO<sub>2</sub>.

Since a small amount of  $O_2$  (5–20%) is involved in  $N_2/O_2$  mixtures in the practical combustion processes, removal technique of NO<sub>2</sub> must be developed in air. FTIR spectra observed before and after 172-nm photolysis of NO<sub>2</sub> were shown in Figure S2a–S2c.<sup>8</sup> Before photolysis, strong NO<sub>2</sub> peak is observed. After 0.5 min photoirradiation, only a small decrease (about 10%) in NO<sub>2</sub> peak intensity was observed. After 1.5 min photoirradiation, the spectrum changed significantly: NO<sub>2</sub> peak disappeared and N<sub>2</sub>O<sub>5</sub>, HNO<sub>3</sub>, and O<sub>3</sub> peaks are observed.

Figure 2 shows the dependence of NO<sub>2</sub> conversion and the formation ratios of N<sub>2</sub>O<sub>5</sub> and HNO<sub>3</sub> and concentration of O<sub>3</sub> on the irradiation time of lamp. The residual amount of NO<sub>2</sub> slowly decreases to 85% in the 0–0.8-min range, suddenly drops to 3% in the 0.8–1.0-min range, and becomes zero at 1.5 min. At about 0.8 min, the formation of N<sub>2</sub>O<sub>5</sub>, HNO<sub>3</sub>, and O<sub>3</sub> starts, and their formation ratios increase in the 0.8–1.0-min range. At 1.5 min, the formation ratios of N<sub>2</sub>O<sub>5</sub> and HNO<sub>3</sub> are 38 and 32%, respectively. The concentration of O<sub>3</sub> rapidly increases from 0.8 to 1.5 min and becomes 714 ppm at 1.5 min. These results indicate that NO<sub>2</sub> can be more efficiently converted to N<sub>2</sub>O<sub>5</sub> and HNO<sub>3</sub> in air in the presence of O<sub>2</sub>.

The reaction mechanisms of NO<sub>2</sub> in N<sub>2</sub> and air are briefly discussed from known photochemical and chemical reactions.<sup>4–6</sup> Rate constants shown below in parenthesis are given in cm<sup>3</sup> molecule<sup>-1</sup> s<sup>-1</sup> units. NO<sub>2</sub> is efficiently decomposed to N<sub>2</sub> and O<sub>2</sub> under 172-nm light in N<sub>2</sub>. Detailed photolysis process of NO<sub>2</sub> at 172 nm has not been known to be best of our knowledge. In a similar 172-nm photolysis of NO, fast decomposition of NO to N<sub>2</sub> and O<sub>2</sub> in N<sub>2</sub> and conversion to NO<sub>2</sub> in air were observed.<sup>7</sup> Therefore, not only direct decomposition of NO<sub>2</sub> into N<sub>2</sub> and O<sub>2</sub> (1) but also multiple step decomposition via NO (2) probably takes part in the photolysis of NO<sub>2</sub> at 172 nm.

$$NO_2 + h\nu (172 \text{ nm}) \rightarrow N + O_2 \tag{1}$$

 $NO_2 + h\nu (172 \text{ nm}) \rightarrow NO + O({}^3P, {}^1D, {}^1S)$  (2a)

$$NO + h\nu (172 \text{ nm}) \rightarrow N + O$$
 (2b)

N and O atoms produced in (2b) will be finally converted to  $N_2$  and  $O_2$  via subsequent reactions in  $N_2$  and air.<sup>1-6</sup> It seems that the latter process is more significant, because direct formation

of  $N + O_2$  from  $NO_2$  will be unfavorable channel.

In air, similar photolysis of NO<sub>2</sub> must occur until 0.8 min. The slower photolysis rate in the short range of 0–0.8 min can be attributed to absorption of 172-nm light by O<sub>2</sub> ( $4.6 \times 10^{-19}$  cm<sup>2</sup> molecule<sup>-1</sup>)<sup>5</sup> and fast backward reaction of NO + O<sub>3</sub>:

$$NO + O_3 \rightarrow NO_2 + O_2 (1.8 \times 10^{-14})$$
 (3)

Actually, the formation of  $O_3$  by the following processes was observed from  $N_2/O_2$  mixtures without addition of  $NO_2$  after 172-nm irradiation (see Figure S3).<sup>8</sup>

$$O_2 + h\nu (172 \,\mathrm{nm}) \to O + O \tag{4a}$$

$$O + O_2 + N_2 \rightarrow O_3 + N_2 (5.6 \times 10^{-34} [N_2])$$
 (4b)

The absence of  $O_3$  in the 0–0.8 min range can be attributed to its fast removal via process (3).

After 0.8 min photoirradiation, the concentration of  $O_3$  exceeds the concentration of NO. Then, the following oxidation reactions of NO<sub>2</sub> leading to N<sub>2</sub>O<sub>5</sub> (5) take place:

$$NO_2 + O_3 \rightarrow NO_3 + O_2 (3.5 \times 10^{-17})$$
 (5a)

$$NO_2 + NO_3 + N_2 \rightarrow N_2O_5 + N_2 (3.6 \times 10^{-30} [N_2])$$
 (5b)

In the photolysis chamber, there is a small amount of residual  $H_2O$  ( $\approx$ 90 ppm), as observed OH peaks from residual  $H_2O$  in FTIR spectra.  $N_2O_5$  has a high reactivity with  $H_2O$  leading to HNO<sub>3</sub>:

$$N_2O_5 + H_2O \rightarrow 2HNO_3 \ (2.5 \times 10^{-22})$$
 (6)

Thus,  $HNO_3$  peaks arise from the result of reaction (6). Reaction (6) is an important reaction, because  $N_2O_5$  can be easily removed as  $HNO_3$  by the addition of  $H_2O$ .

The effects of  $O_2$  concentration in  $N_2/O_2$  mixtures were examined in the 5–20% range. With increasing the  $O_2$  concentration from 5% to 10 and 20%, the formation of  $N_2O_5$  starts at shorter time of 1 min.

In summary, NO<sub>2</sub> removal by 172-nm excimer lamp has been studied. It was found that NO<sub>2</sub> in air can efficiently be converted to N<sub>2</sub>O<sub>5</sub> using O<sub>3</sub> generated from 172-nm photolysis of O<sub>2</sub>. Since N<sub>2</sub>O<sub>5</sub> can be easily converted to HNO<sub>3</sub> by the addition of H<sub>2</sub>O, the present results are useful as a new simple and low cost photochemical aftertreatment technique of NO<sub>2</sub> in air without using any catalysts.

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## **References and Notes**

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